Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/041,761	YOON ET AL.	
Examiner	Art Unit	
Hung Q. Dang	2633	

SEARCHED			
Class	Subclass	Date	Examiner
386	125	8/1/2006	HQD
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
inventors' name search	7/25/2006	HQD
STIC Plus Search	6/2/2006	HQD
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	7/25/2006	HQD
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